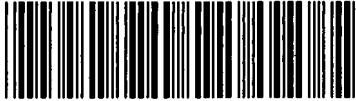


<b>Search Notes</b> 	<b>Application/Control No.</b> 10760393	<b>Applicant(s)/Patent Under Reexamination</b> LAI ET AL.
	<b>Examiner</b> Paliwal, Yogesh	<b>Art Unit</b> 2135

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor name search in (East+ Google+ IEEE)	6/5/2007	YP
(713/193) + Keywords -See search history printout	6/5/2007	YP
(713/189) + Keywords -See search history printout	6/5/2007	YP
(713/192) + Keywords -See search history printout	6/5/2007	YP
(713/ and 380/) + Keywords - See search history printout	6/5/2007	YP
Other key word search in East - See search history printout	6/5/2007	YP
Keyword search in Google Scholar- See search history printout	6/5/2007	YP

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>